Search Notes		

Application/Control No.	Applicant(s)/Patent Reexamination	under
10/556,962	LEE ET AL.	
Examiner	Art Unit	
THUAND DANG	4707	

	SEARCHED		
Class	Subclass	Date	Examiner
585	469	6/7/2008	TD

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH (INCLUDING SEAF		<u></u>
	DATE	EXMR
East	6/7/2008	TD
Inventorship search	6/7/2008	TD